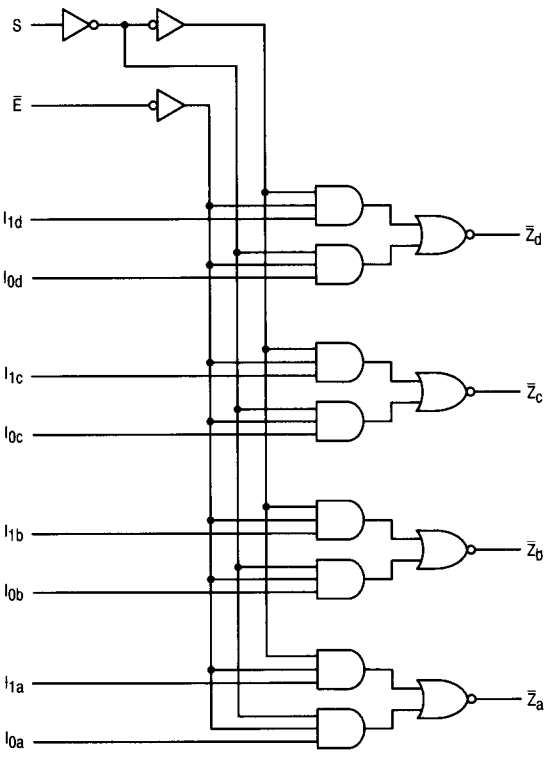
MOTOROLA

Quad 2-Input Data Selector/Multiplexer With Inverted Outputs

ELECTRICALLY TESTED PER:
MIL-M-38510/33904

The 54F158A is a high-speed quad 2-input multiplexer. It selects four bits of data from two sources using the common Select and Enable inputs. The four buffered outputs present the selected data in the true inverted form. The 'F158A can also be used to generate any four of the 16 different functions of two variables.

LOGIC DIAGRAM



Military 54F158A

AVAILABLE AS:

1) JAN: JM38510/33904BXA
2) SMD: N/A
3) 883: 54F158A/BXAJC

X = CASE OUTLINE AS FOLLOWS:
PACKAGE: CERDIP: E
CERFLAT: F
LCC: 2

THE LETTER "M" APPEARS BEFORE THE / ON LCC.

PIN ASSIGNMENTS

FUNCT.	DIL 620-09	FLATS 650-05	LCC 756A-02	BURN-IN (COND. A)
S	1	1	2	V_{CC}
I_{0a}	2	2	3	V_{CC}
I_{1a}	3	3	4	V_{CC}
$\overline{Z}_a$	4	4	5	OPEN
I_{0b}	5	5	7	V_{CC}
I_{1b}	6	6	8	V_{CC}
$\overline{Z}_b$	7	7	9	OPEN
GND	8	8	10	GND
$\overline{Z}_d$	9	9	12	OPEN
I_{1d}	10	10	13	V_{CC}
I_{0d}	11	11	14	V_{CC}
$\overline{Z}_c$	12	12	15	OPEN
I_{1c}	13	13	17	V_{CC}
I_{0c}	14	14	18	V_{CC}
$\overline{E}$	15	15	19	V_{CC}
V_{CC}	16	16	20	V_{CC}

BURN-IN CONDITIONS:
V_{CC} = 5.0 V MIN/6.0 V MAX

TRUTH TABLE

Inputs				Output
$\overline{E}$	S	I_{0n}	I_{1n}	$\overline{Z}_n$
H	X	X	X	H
L	L	L	X	H
L	L	H	X	L
L	H	X	L	H
L	H	X	H	L

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

FUNCTIONAL DESCRIPTION

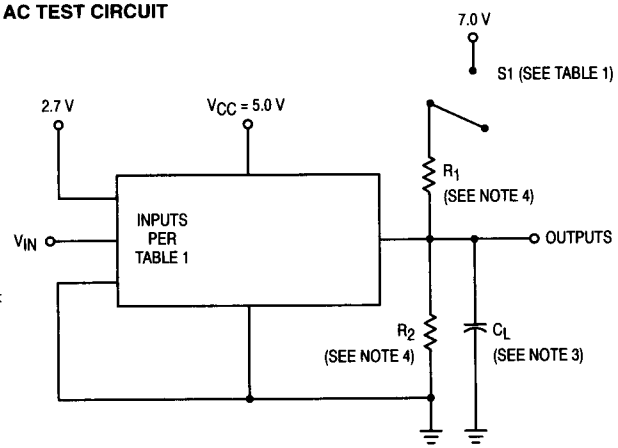
The F158A is a quad 2-input multiplexer. It selects four bits of data from two sources under the control of a common Select input (S) and presents the data in inverted form at the four outputs. The Enable input ($\overline{E}$) is active LOW. When $\overline{E}$ is HIGH, all of the outputs ($\overline{Z}$) are forced HIGH regardless of all other inputs. The F158A is the logic implementation of a 4-pole, 2-position switch where the position of the switch is determined by the logic levels supplied to the Select Input.

A common use of the F158A is the moving of data from two groups of registers to four common output busses. The particular register from which the data comes is determined by the state of the Select input. A less obvious use is as a function generator. The F158A can generate Four functions of two variables with one variable common. This is useful for implementing gating functions.

AC TEST CIRCUIT

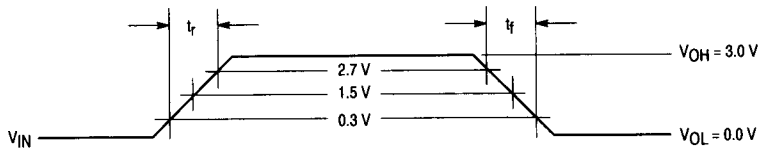
Table 1

Test Type	S1
t_{PLH}	open
t_{PHL}	open
t_{PHZ}	open
t_{PZH}	open
t_{PLZ}	closed
t_{PZL}	closed

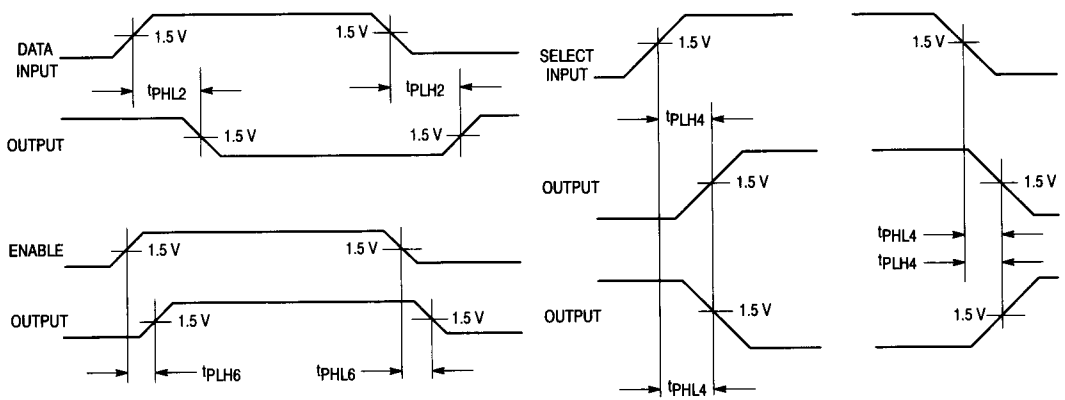


NOTES:

1. V_{IN} = Input pulse and has the following characteristics: PRR ≤ 1.0 MHz, $t_r = t_f \leq 2.5$ ns, $Z_{IN} \approx 50\ \Omega$.
2. Terminal conditions (pins not designated may be high ≥ 2.0 V, low ≤ 0.8 V, or open).
3. $C_L = 50$ pF ± 10% including scope probe, wiring and stray capacitance, without package in test fixture.
4. $R_1 = R_2 = 499\ \Omega \pm 5.0\%$.
5. Voltage measurements are to be made with respect to network ground terminal.



WAVEFORMS



Symbol	Parameter	Limits						Unit	Test Condition (Unless Otherwise Specified)
	Static Parameters:	+ 25°C		+ 125°C		− 55°C			
		Subgroup 1		Subgroup 2		Subgroup 3			
		Min	Max	Min	Max	Min	Max		
V_{OH}	Logical "1" Output Voltage	2.5		2.5		2.5		V	V_{CC} = 4.5 V, I_{OH} = −1.0 mA, V_{IH} = 2.0 V, S = 0.8 V or 2.0 V, V_{IL} = 0.8 V, $\overline{E}$ = 0.8 V.
V_{OL}	Logical "0" Output Voltage		0.5		0.5		0.5	V	V_{CC} = 4.5 V, I_{OL} = 20 mA, V_{IL} = 0.8 V, S = 0.8 V or 2.0 V, V_{IN} = 2.0 V, $\overline{E}$ = 0.8 V.
V_{IC}	Input Clamping Voltage		−1.2					V	V_{CC} = 4.5 V, I_{IN} = −18 mA, other inputs are open.
I_{IH}	Logical "1" Input Current		20		20		20	µA	V_{CC} = 5.5 V, V_{IH} = 2.7 V, other inputs are open, $\overline{E}$ = 4.5 V or (2.7), S = 4.5 V, 0 V or (2.7 V).
I_{IHH}	Logical "1" Input Current		100		100		100	µA	V_{CC} = 5.5 V, V_{IHH} = 7.0 V, other inputs are open, $\overline{E}$ = 4.5 V or (7.0 V), S = 4.5 V, 0 V or (7.0 V).
I_{IL}	Logical "0" Input Current	−0.03	−0.6	−0.03	−0.6	−0.03	−0.6	mA	V_{CC} = 5.5 V, V_{IN} = 0.5 V, other inputs are open, $\overline{E}$ = 0 V, S = 0.5 V, 4.5 V or (0.5 V).
I_{OD}	Diode Current	60		60		60		mA	V_{CC} = 4.5 V, V_{IN} = 5.5 V, other inputs are open, V_{OUT} = 2.5 V, S & $\overline{E}$ = 0 V.
I_{OS}	Output Short Circuit Current	−60	−150	−60	−150	−60	−150	mA	V_{CC} = 5.5 V, V_{IN} = 4.5 V or 0 V, all other inputs are open, V_{OUT} = 0 V, S = 0 V, $\overline{E}$ = 0 V.
I_{CC}	Power Supply Current		15		15		15	mA	V_{CC} = 5.5 V, V_{IN} = 4.5 V (all inputs).
V_{IH}	Logical "1" Input Voltage	2.0		2.0		2.0		V	V_{CC} = 4.5 V.
V_{IL}	Logical "0" Input Voltage		0.8		0.8		0.8	V	V_{CC} = 4.5 V.
	Functional Tests	Subgroup 7		Subgroup 8A		Subgroup 8B			per Truth Table with V_{CC} = 4.5 V, (**Repeat at**) V_{CC} = 5.5 V, V_{INL} = 0.5 V, and V_{INH} = 2.5 V.

Symbol	Parameter	Limits						Unit	Test Condition (Unless Otherwise Specified)
	Switching Parameters:	+ 25°C		+ 125°C		− 55°C			
		Subgroup 9		Subgroup 10		Subgroup 11			
		Min	Max	Min	Max	Min	Max		
t_{PHL2}	Propagation Delay /Data-Output I_n to $\overline{Z}$	1.5	4.0	1.5	5.0	1.5	5.0	ns	V_{CC} = 5.0 V, C_L = 50 pF, $R_1 = R_2$ = 499 Ω
t_{PLH2}	Propagation Delay /Data-Output I_n to $\overline{Z}$	2.5	5.9	2.5	8.5	2.5	8.5	ns	V_{CC} = 5.0 V, C_L = 50 pF, $R_1 = R_2$ = 499 Ω
t_{PHL6}	Propagation Delay /Data-Output $\overline{E}$ to $\overline{Z}_n$	2.0	6.0	2.0	7.0	2.0	7.0	ns	V_{CC} = 5.0 V, C_L = 50 pF, $R_1 = R_2$ = 499 Ω
t_{PLH6}	Propagation Delay /Data-Output $\overline{E}$ to $\overline{Z}_n$	2.5	6.0	2.5	8.0	2.5	8.0	ns	V_{CC} = 5.0 V, C_L = 50 pF, $R_1 = R_2$ = 499 Ω
t_{PHL4}	Propagation Delay /Data-Output S to $\overline{Z}$	2.5	6.5	2.5	8.0	2.5	8.0	ns	V_{CC} = 5.0 V, C_L = 50 pF, $R_1 = R_2$ = 499 Ω
t_{PLH4}	Propagation Delay /Data-Output S to $\overline{Z}$	3.0	8.5	3.0	10.5	3.0	10.5	ns	V_{CC} = 5.0 V, C_L = 50 pF, $R_1 = R_2$ = 499 Ω